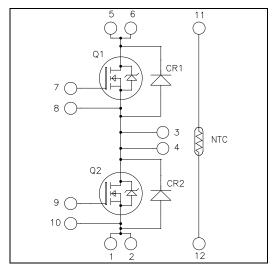
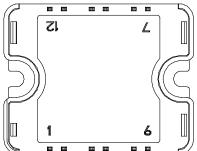


# Phase leg <u>SiC MOSFET P</u>ower Module





Pins 1/2; 3/4; 5/6 must be shorted together

# $$\begin{split} V_{DSS} &= 1200V \\ R_{DSon} &= 17 m\Omega \text{ max } @.\text{Tj} = 25^{\circ}\text{C} \\ I_D &= 143 \text{A} @.\text{Tc} = 25^{\circ}\text{C} \end{split}$$

#### **Application**

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- SiC Power MOSFET
  - Low R<sub>DS(on)</sub>
  - High temperature performance

#### • SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

## All ratings @ $T_i = 25$ °C unless otherwise specified

## 1. SiC MOSFET characteristics (Per MOSFET)

Symbol	Parameter	Max ratings	Unit		
$V_{ m DSS}$	Drain - Source Breakdown Voltage		1200	V	
т	Continuous Drain Current	$T_c = 25^{\circ}C$	143		
$I_{D}$	Continuous Drain Current	$T_c = 80$ °C	108	A	
$I_{DM}$	Pulsed Drain current		280		
$V_{GS}$	Gate - Source Voltage	Sate - Source Voltage			
R <sub>DSon</sub>	Drain - Source ON Resistance		17	mΩ	
$P_{D}$	Maximum Power Dissipation	$T_c = 25^{\circ}C$	600	W	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



#### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ , $V_{DS} = 1200V$			20	200	μΑ
D	Duning Common on Boninton	$V_{GS} = 20V$ $T_j = 2$	$T_j = 25^{\circ}C$		12.5	17	
R <sub>DS(on)</sub>	Drain – Source on Resistance	$I_{\rm D} = 100 A$	$T_{j} = 150^{\circ}C$		22	32	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 2mA$		1.9	2.3		V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				1	μA

**Dynamic Characteristics** 

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 1000V$			5960		
$C_{oss}$	Output Capacitance				440		pF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz			46		
$Q_{g}$	Total gate Charge	$V_{GS} = -2/+20V$			360		
$Q_{gs}$	Gate – Source Charge	$V_{\text{Bus}} = 800V$			64		nC
$Q_{gd}$	Gate – Drain Charge	$I_{\rm D} = 100 A$			126		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -2/+20V$			21		
$T_{\rm r}$	Rise Time	$V_{\text{Bus}} = 800V$			19		
$T_{d(off)}$	Turn-off Delay Time	$I_D = 100A$		50		ns	
$T_{\mathrm{f}}$	Fall Time	$R_L = 8\Omega$ ; $R_G = 10\Omega$			30		
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$	$T_{j} = 150^{\circ}C$		2.2		m I
$E_{\text{off}}$	Turn off Energy	$I_{D} = 100A$ $R_{G} = 10\Omega$	$T_j = 150$ °C		1.2		mJ
$R_{\text{thJC}}$	Junction to Case Thermal Resistance	e				0.21	°C/W

# 2. SiC diode characteristics (Per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			1200			V
$I_{RM}$	Maximum Reverse Leakage Current	$V_R=1200V$ $T_j=2$	$T_j = 25$ °C		70	400	μA
1 <sub>RM</sub>	Waximum Reverse Leakage Current	V R-1200 V	$T_j = 175$ °C		130	800	μА
$I_F$	DC Forward Current		Tc = 125°C		40		A
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_F = 40A$ $T_j =$	$T_i = 25^{\circ}C$		1.5	1.8	V
<b>v</b> <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 40A	$T_{i} = 175^{\circ}C$		2.2	3	V
Qc	Total Capacitive Charge	$I_F = 40A, V_R = 1200V$ $di/dt = 1000A/\mu s$			260		nC
C	Total Canacitanas	$f = 1 MHz, V_R = 200 V$	200V	186			ъE
	Total Capacitance	$f = 1MHz, V_R =$	400V		134		pF
$R_{\text{thJC}}$	Junction to Case Thermal Resistance					0.7	°C/W



## 3. Thermal and package characteristics

## Package characteristics

Symbol	Characteristic		Min	Typ	Max	Unit		
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz			4000			V	
Т	Operating junction temperature range		SiC MC	SFET	-40		150	
$T_{J}$	SiC diode		-40		175			
$T_{JOP}$	Recommended junction temperature under switching conditions		-40		$T_J$ max	°C		
	Recommended junction temperature under switching conditions				-25			
$T_{STG}$	Storage Temperature Range				-40		125	
$T_{\rm C}$	Operating Case Temperature			-40		125		
Torque	Mounting torque	To hea	atsink	M4	2		3	N.m
Wt	Package Weight				80	g		

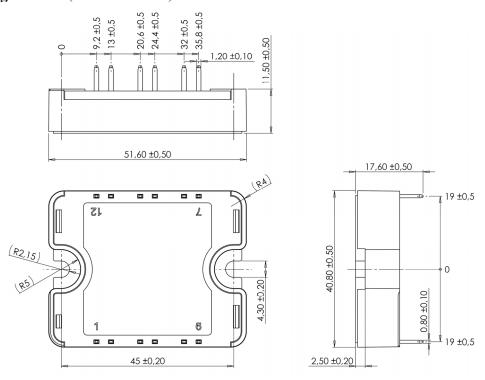
#### Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic		Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T <sub>C</sub> =100°C		4		%

$$R_T = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$

$$R_T: \text{ Thermistor value at T}$$

## SP1 Package outline (dimensions in mm)

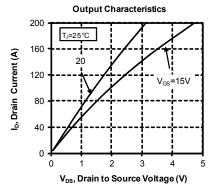


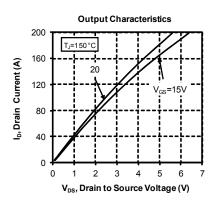
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

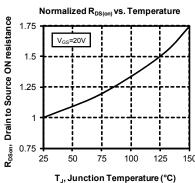


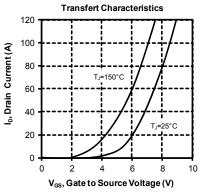
## 4. Typical Performance Curves

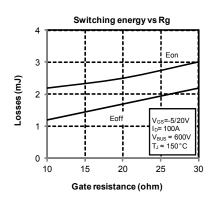
#### SiC MOSFET

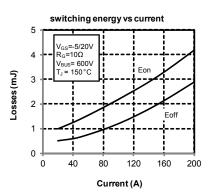


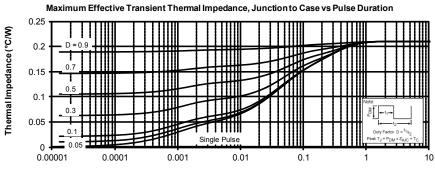






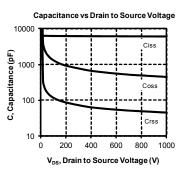


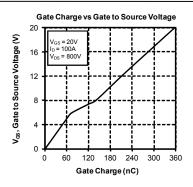


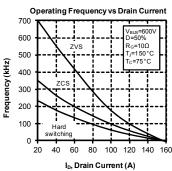


rectangular Pulse Duration (Seconds)

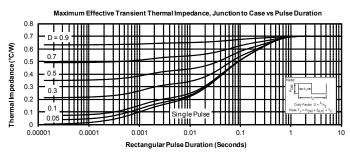


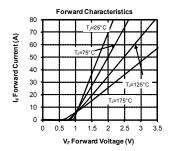


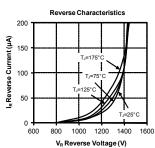


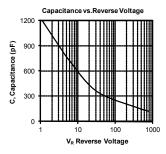


#### SiC diode









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